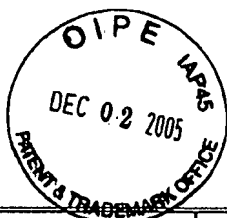


INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 58799-104		SERIAL NO. Continuation of Appl. No. 09/659,559	
				APPLICANT Taku NAKAMURA, et al.			
				FILING DATE January 23, 2004		GROUP	
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						Yes	No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
		EXAMINER	DATE CONSIDERED <div style="font-size: 1.5em; margin-top: 10px;">12/5/07</div>				

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SHEET 1 OF 1INFORMATION DISCLOSURE
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.